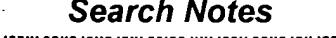


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/903,709	OUCHI ET AL.
Examiner	Art Unit	
Richard H. Kim	2871	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Same As Above		3/1/2005	RHK